

MC3210-VB Datasheet

N-Channel 30 V (D-S) MOSFET

FEATURES

Trench power MOSFET

APPLICATIONS

- Notebook PC

· Load switches

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) Q _g (TY				
30	0.016 at V_{GS} = 10 V	9	9 nC			
30	0.019 at V _{GS} = 4.5 V	8	910			

DFN 3x2







ABSOLUTE MAXIMUM RATINGS ($T_A = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	30	V		
Gate-Source Voltage		V _{GS}	± 20	v		
	T _C = 25 °C		9			
Continuous Drain Current (T 150 °C)	T _C = 70 °C	Ι.	6 ^a			
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	T _A = 25 °C	I _D	6 ^{a, b, c}			
	T _A = 70 °C		6 ^{a, b, c}	A		
Pulsed Drain Current		I _{DM}	30			
Continuous Courses Drain Diada Current	T _C = 25 °C		5.2			
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.1 ^{b, c}			
	T _C = 25 °C		6.3			
Mauian Daniar Diania atian	T _C = 70 °C		4	w		
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	vv		
	T _A = 70 °C		1.6 ^{b, c}			
Operating Junction and Storage Temperatur	e Range	T _J , T _{stg}	-55 to +150			
Soldering Recommendations (Peak Tempera	ature) ^{e, f}	-	260			

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a, c, d	t ≤ 5 s	R _{thJA}	40	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	15	20	0/10		

Notes

a. Package limited, $T_C = 25$ °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s

d. Maximum under steady state conditions is 95 °C/W.

e. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

f. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

MC3210-VB

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	<u>.</u>					•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	/Τ_		31	-	m)//°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-5.1	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.2	-	2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-	-	± 100	nA
	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	1	μA
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$	-	-	5	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V$, $V_{GS} = 10 V$	20	-	-	А
	_	V _{GS} = 10 V, I _D = 9.1 A	-	0.016	-	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8.1 \text{ A}$	-	0.019	-	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 9.1 A	-	30	-	S
Dynamic ^b	<u> </u>					
Input Capacitance	C _{iss}		-	1200	-	
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	-	180	-	pF
Reverse Transfer Capacitance	C _{rss}		-	80	-	
Total Gate Charge	Q _g	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 9.1 \text{ A}$	-	19	29	nC
			-	9	14	
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 9.1 \text{ A}$	-	3.5	-	
Gate-Drain Charge	Q _{gd}		-	2.3	-	
Gate Resistance	Rg	f = 1 MHz	-	3	-	Ω
Turn-On Delay Time	t _{d(on)}		-	20	30	-
Rise Time	t _r	V_{DD} = 15 V, R_L = 2.1 Ω	-	12	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7.3$ Å, $V_{GEN} = 4.5$ V, $R_g = 1$ Ω	-	20	30	
Fall Time	t _f		-	10	15	
Turn-On Delay Time	t _{d(on)}		-	10	15	ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 2.1 \Omega$	-	10	15	-
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong7.3$ A, V_GEN = 10 V, R_g = 1 Ω	-	20	30	
Fall Time	t _f		-	10	15	
Drain-Source Body Diode Characteristi	cs				•	•
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	5.2	
Pulse Diode Forward Current	I _{SM}		-	-	30	A
Body Diode Voltage	V _{SD}	$I_{\rm S}$ = 7.3 A, $V_{\rm GS}$ = 0 V	-	0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}		-	20	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	10	20	nC
Reverse Recovery Fall Time	t _a	I _F = 7.3 A, dl/dt = 100 A/μs, T _J = 25 °C	-	11	-	
Reverse Recovery Rise Time	t _b			9	-	ns

Notes

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

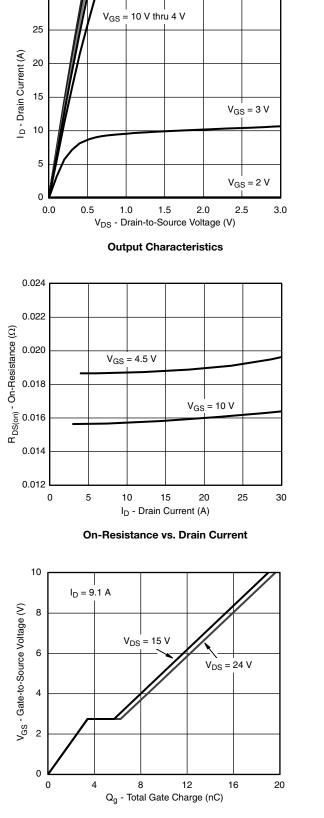
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

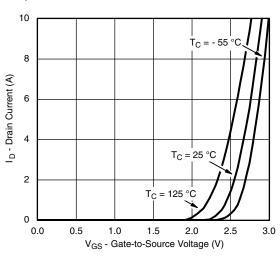
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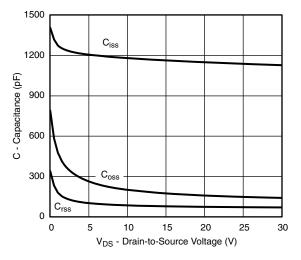
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



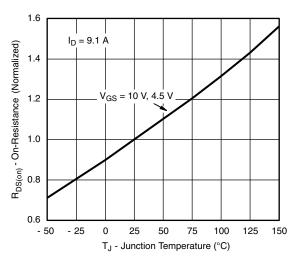
Gate Charge



Transfer Characteristics

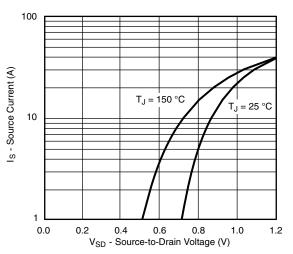






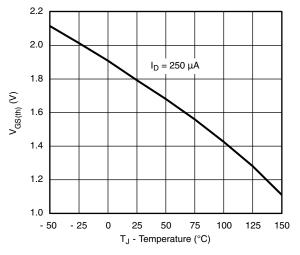
On-Resistance vs. Junction Temperature



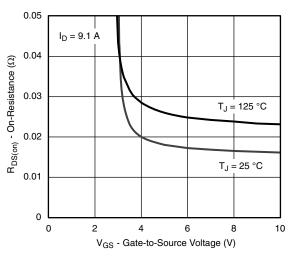


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

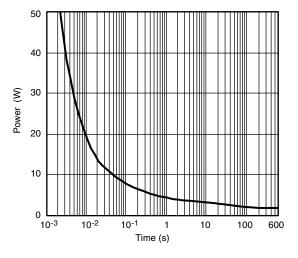




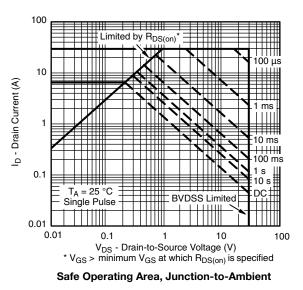




On-Resistance vs. Gate-to-Source Voltage

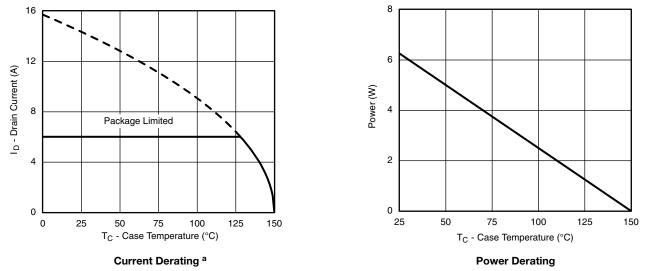








TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

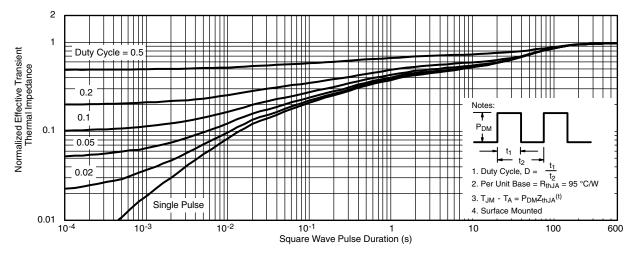


Note

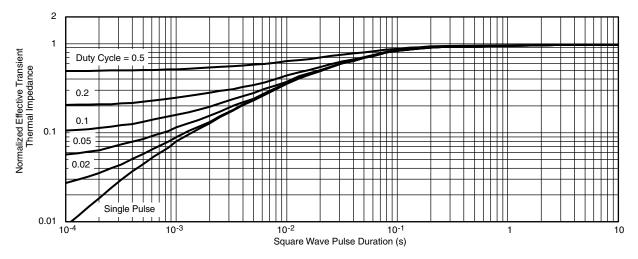
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



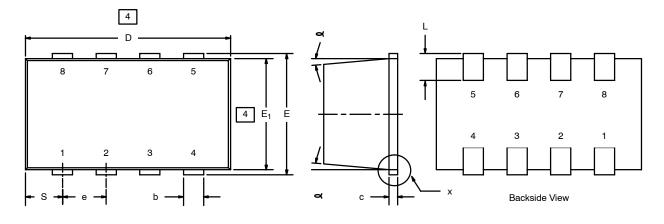
Normalized Thermal Transient Impedance, Junction-to-Ambient

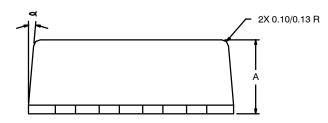


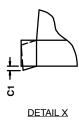
Normalized Thermal Transient Impedance, Junction-to-Foot



DFN 3x2







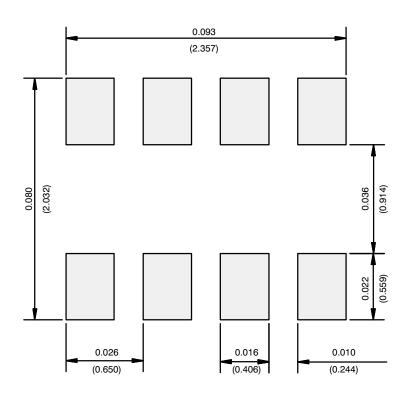
NOTES:

- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- 3. Leadframe to molded body offset is horizontal and vertical shall not exceed 0.08 mm.
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039	-	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
C	0.1	0.15	0.20	0.004	0.006	0.008	
c1	0	-	0.038	0	-	0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.825	1.90	1.975	0.072	0.075	0.078	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.0256 BSC			
L	0.28	-	0.42	0.011	-	0.017	
s	0.55 BSC			0.022 BSC			
ک	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							



RECOMMENDED MINIMUM PADS FOR DFN3x2



Recommended Minimum Pads Dimensions in Inches/(mm)



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